TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (π - MOSI)

HIGH SPEED, HIGH CURRENT SWITCHING APPLICATIONS. CHOPPER REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE APPLICATIONS.

FEATURES :

- Low Drain-Source ON Resistance : R_{DS(ON)}=0.3Ω (Typ.)
- . High Forward Transfer Admittance : |Y_{fs}|=11S (Typ.)
- . Low Leakage Current : $I_{GSS}{=}\pm500 nA(Max.)$ @ $V_{GS}{=}\pm20V$ $I_{DSS}{=}250 \mu A~(Max.)$ @ $V_{DS}{=}500V$
- . Enhancement-Mode : Vth=2.04.0V @ VDS=VGS.ID=250µA

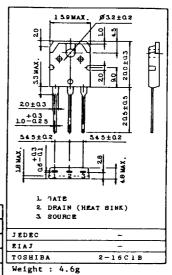
www.DataSheMAXIMUM RATINGS (Ta=25°C)

CHARACTI	ERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage		VDSX	500	v
Drain-Gate Vol	age (R _{GS} =20kΩ)	VDGR	500	v
Gate-Source Voltage		V _{GSS}	±20	v
Drain Current	DC	ID	13	
brain Current	Pulse	I _{DP}	52	A
Drain Power Dissipation (Tc=25°C)		PD	150	W
Channel Tempera		Tch	150	°C
Storage Temperature Range		Tstg	-55^150	°C

INDUSTRIAL APPLICATIONS Unit in mm

YTFP450

T-37-13



THERMAL	CHARACTERISTICS
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CHARACTERISTIC	SYMBOL	MAX.	UNIT]
Thermal Resistance, Junction to Case	Rth(j-c)	0.83	°C/W]
Thermal Resistance, Junction to Ambient	R _{th(j-a)}	wyow L	ata Sheet	l 411 co
Muximum Lead Temperature for Soldering Purposes (1.6mm from case for 10 seconds)	TL	300	°C	10100

ELECTRICAL CHARACTERISTICS (Ta=25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		I _{GSS}	V _{GS} =±20V, V _{DS} =OV	-	-	±500	nA
Drain Cut-off C	irrent	IDSS	V _{DS=500} V, V _{GS=0} V	-	-	250	μA
Drain-Source Brea	kdown Voltage	V(BR)DSS	I _D =250μA, V _{GS} =0V	500	-	-	v
Gate Threshold	/oltage	V _{th}	V _{DS} =V _{GS} , I _D =250µA	2.0	-	4.0	ν
Forward Transfer	Admittance	Yfs	V _{DS} =10V, I _D =7A	6.0	11	-	S
Drain-Source ON Resistance		R _{DS(ON)}	ID=7A , NGS=10N	-	0.3	0.4	Ω
Drain-Source ON Voltage		VDS(ON)	I _D =13A , V _{GS} =10V	-	4.3	6.3	ν
Input Capacitance		Ciss	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	2000	3000	pF
Reverse Transfer Capacitance		Crss		-	100	200	
Output Capacitance		Coss		-	370	600	
	Rise Time	tr	10V VIN DE 7A	-	25	50	ns
Switching Time	Turn-on Time	ton		-	40	85	
	Fall Time	tf		-	35	70	
	Turn-off Time		VIN:tr,tf<5ns V _{DD} ⇒210V Duty≤1%	-	110	220	
Total Gate Charge (Gate-Source Pius Gate-Drain)		Qg	ID=16A , V _{GS} =10V V _{DD} =400V	-	82	120	
Gate-Source Charge		Qgs		-	40	-	nC
Gate-Drain ("Miller") Charge		Qgd	*DD00*	-	42	-	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS $(Ta=25^{\circ}C)$

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	IDR		-	-	13	A
Pulse Drain Reverse Current	IDRP		-	-	52	A
Diode Forward Voltage	VDSF	IDR= 13A, VGS=OV	-	-	1.4	V.
Reverse Recovery Time	trr	I _{DR} =13A	-	1300	-	ns
Reverse Recovered Charge	Qrr	dI _{DR} /dt=100A/µs	-	7.4	-	μC

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